Studies on the Deposition Behavior of Pt[(NH₃)₂(H₂O)₂]⁺² Complex Bath

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The elctrodeposition behavior of platinum from the $Pt[(NH_3)_2(H_2O)_2]^{+2}$ complex bath was investigated on copper and titanium panels and the deposits were characterised by SEM, XRF and XRD techniques. The current efficiencies for the deposition process were examined. The bath deposits bright and adherent coatings. The bath operates at lower temperatures than the Q-bath.

Key words: Electrodeposition, pre-electrolysis, polarization, ligand substitution

Introduction

Platinum is extensively used as a coating material onto the activation components, turbine blades, electrodes, electronic components and jewellery to impart corrosion resistance or pleasing appearance. Platinum electroplating is usually carried out using baths based on P-salt or Q-salt. However, these baths suffer from certain drawbacks such as high operating temperature and low plating current densities. These limitations lead to the explorations in the developments of new baths based on Pt[(H,O)]⁺² complex species [1]. The present study describes the results on theplating behavior of bath derived from cis-Pt[(NH₃)₂(H₂O)₂]⁺² complex solution. The techniques like Scanning Electron Microscopy (SEM), X-Ray Diffraction (XRD) techniques and X-Ray Fluorescence (XRF) were used to characterise the deposited coatings.

Experimental

The complexes cis-Pt[(NH₃)₂(I)₂]⁺² and cis-Pt[(NH₃)₂(H₂O)₂]⁺² were prepared by a known procedure after some modifications [2]. K₂PtCl₄ (0.5 g, 1.2 mM) was dissolved in 50 ml of water and aqueous HI (5.2 mM) was added while stirring. A dark brown solution was formed after 10 minutes. To this, NH₄Cl (2.5 mM) and 1 ml of 50 % aqueous ammonia were added with stirring. After a period of 15-20 minutes, the complex cis-Pt[(NH₃)₂(I)₂]⁺² was precipitated as a mustard colored material. This was filtered, washed with cold distilled water and dried at room temperature. This cis-Pt[(NH₃)₂(I)₂]⁺² complex (0.350 g, 0.72 mM) was dissolved in 100 ml of

The plating experiments were performed on copper and titanium panels of exposed area of 1 cm x 2 cm for a period of 0.5 to 1 hr in 100 ml cell using Pt foil as the anode. Copper panels were electrocleaned in alkaline cleaner and titanium was chemically cleaned in conc. HCl containing some HF. The pH of the bath was adjusted to 10.4 after the addition of Na₂HPO₄ (0.78 mole) with dil. NaOH solution. The thickness of the platinum deposits was determined by XRF method using Coating Measurement Instruments [CMI] of type XRX-XYZ and the measurements are accurate by +/- 0.001 microns. SEM was recorded on Hitachi S-300 H instrument and the XRD spectra were recorded by using a JEOL instrument.

Results and discussion

It is well known in the literature that the electroactive species in the plating baths containing $Pt[(NH_3)_4]^{+2}$ complex is not simply $Pt[(NH_3)_4]^{+2}$, when the plating is carried out at temperatures between 363 - 368 K, but $Pt[(NH_3)_{4-x}(H_2O)_x]^{+2}$ (where x = 1 - 3) [3]. At these high temperatures, it was suggested that,

distilled water by heating to 343 K. To this $AgClO_4$ (0.298g, 1.44 mM) in water was added slowly over a period of one hour. The heating and stirring was continued for two more hours after that, the precipitated AgI was filtered off to get a clear colorless solution of *cis*-Pt[(NH₃)₂(H₂O)₂](ClO₄)₂ of 3.30 g/l concentration. The excess Ag⁺ was removed by pre-electolysis at 0.25 V (vs. SCE) using large platinum foils until there are no further black deposits of silver metal on the cathode.

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there will be a ligand substitution reaction in the original platinum complex by water molecules. As the substitution at Pt centers is known to be slow it is necessary to have higher temperatures for a faster ligand substitution [4,5]. Hence the plating baths should have such high working temperatures and this working temperature can be significantly reduced when complexes of the type Pt[(NH₃)_{4-x}(H₂O)_x]⁺² (x = 1-4) are used. This is indeed demonstrated in the present investigation, as only 343 K temperature is needed (compared to 363 - 368 K) for an acceptable deposition. The most likely mechanism in the deposition process can be

$$Pt[(NH_{3})_{2}(H_{2}O)_{2}]^{+2} + x H_{2}O \longrightarrow Pt[(NH_{3})_{2-x}(H_{2}O)_{x+2}]^{+2}$$

(where x = 1 or 2) + 2 e⁻ \rightarrow Pt⁰

The polarization behavior for the elctrodeposition of platinum on copper and titanium electrodes are shown in Figs.1 and 2 respectively. The current efficiency of the bath was examined on copper panels at temperatures 333, 343, 353 and 363 K, at a current density of 0.5 mA/cm^2 . The results showed that a maximum efficiency of 72 % could be obtained at 343 K, after which the efficiency decreases with increase of temperature. The thickness obtained was 0.56 micron at these conditions within half-an-hour plating time. The data are collected in Table 1. The deposits are bright and adherent to the substrate. Fig.3 shows the optical micrograph of 0.5-micron thick platinum deposit. Owing to its lower thickness, a proper XRD spectrum of this coating was not obtained. The efficiency of the bath was also checked at various current densities, viz., 1, 2 and 3 mA/cm² for one hour at 343 K (Table 1). The results showed that the efficiency decreased with current density, but the deposits are still bright and adherent.



Fig.1. Polarisation curve for the electrodeposition of Pt on copper panel.



Fig. 2. Polarisation curve for the electrodeposition of Pt or titanium panel.



Fig. 3. Scanning electron micrograph (x1000) of Pt coating or copper panel.

Table 1. Data on platinum deposition on copper. Concentration of bath = 3.5 g/l of Pt., Time = 0.5 h and pH = 10.4

C. D (mA/cm2)	Temp. (K)	C. E. (%)	Thickness (microns)
0.5	333	39	0.37
0.5	343	72	0.56
0.5	353	50	0.41
0.5	363	44	0.36
0.5	343	72	0.56
1	343	50	0.84
2	343	20	0.67
3	343	10	0.5

The plating behavior of the bath was also investigated on titanium substrates. The data is summarized in Table 2. The maximum current efficiency of 90 % is obtained when the current density is 0.5 mA/cm². Further increase in current density resulted in decline of efficiency. The coatings were bright and adherent, but less bright compared to coating on the copper panel. SEM analysis of the above deposit shows that coating is uniform. Under higher resolution, the structure showed a cauli-flower type surface morphology. The scanning electron micrographs are shown in Figs. 4 and 5. XRD spectrum was also recorded. The XRD pattern has indicated that polycrystalline film of platinum with plane orientations (111), (200), (220), (311) and (222) were deposited.



Fig. 4. Scanning electron micrograph (x 1000) of Pt coating on titanium panel.



Fig. 5. Scanning electron micrograph (x 5000) of Pt coating on titanium panel.

Table 2. Data on platinum deposition on titanium panel. Concentration of bath = 3.5 g/l of Pt., Time = 1 h, pH = 10.4 and Temperature = 343 K

C.D. (mA/cm ²)	C. E. (%)	Thickness (micron)
0.5	90	0.5
1	40	0.4
2	15	0.27
3	7	0.25
5	6	0.24

Conclusion

The electrodeposition behavior of platinum from the $Pt[(NH_3)_2(H_2O)_2]^{+2}$ complex bath was investigated and SEM and XRD techniques were used to characterize the deposits. The current efficiencies for the deposition process on copper and titanium panels were found to be decreased as the current density is increased. The bath deposits are bright and adherent. The bath operates at lower temperatures than the Q-bath.

References

- 1. Johnson Mathey Technology, G.B. Patent Application, 92/12831.3 b.
- Adrian J Gregory, William Levason, Derek Pletcher, J. Electroanal. Chem., 348 (1993) 211.
- Adrain .J. Gregory, William Levason, Ronald E. Noftle, Roselyne Le Penven, Derek Pletcher, J. Electroanal. Chem., 399 (1995) 105.
- 4. Roselyne Le Penven, William Levason, Derek Pletcher, J. Applied Electrochem., 22 (1992) 415.
- F. Basalo and R. G. Pearson, Mechanism of Inorganic Reactions, Wiley, New York (1967).
- 6. R. J. Cross, Advances in Inorganic Chemistry, 34 (1989) 219.